



# BSS138BE

## N-Channel Enhancement Mode Field Effect Transistor

### Product Summary

$V_{DS}$	50V
$I_D$	300mA
$R_{DS(ON)}$ ( at $V_{GS}=10V$ )	1100m
$R_{DS(ON)}$ ( at $V_{GS}=4.5V$ )	1200m

### General Description

Trench Power MV MOSFET technology  
Voltage controlled small signal switch  
Low input Capacitance  
Fast Switching Speed  
Low Input / Output Leakage  
Moisture Sensitivity Level 1  
Epoxy Meets UL 94 V-0 Flammability Rating  
Halogen Free

### Applications

Battery operated systems  
Solid-state relays  
Direct logic-level interface TTL/CMOS

### Absolute Maximum Ratings ( $T_A=25$ unless otherwise noted)

Parameter	Symbol	Limit	Unit	
Drain-source Voltage	$V_{DS}$	50	V	
Gate-source Voltage	$V_{GS}$	$\pm 20$	V	
Drain Current	$I_D$	$T_A=25$	300	mA
		$T_A=100$	189	



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## Electrical Characteristics ( $T_J=25$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	U/P $\theta_{eW}$
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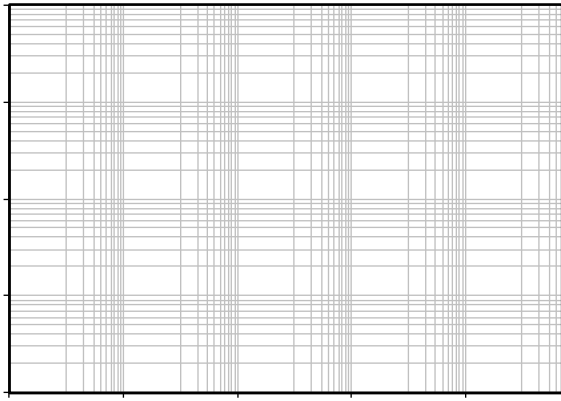


Figure 13. Maximum Transient Thermal Impedance

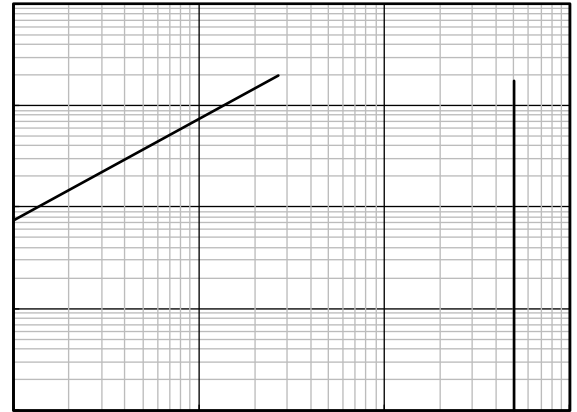


Figure 14. Safe Operation Area

## Test Circuits & Waveforms

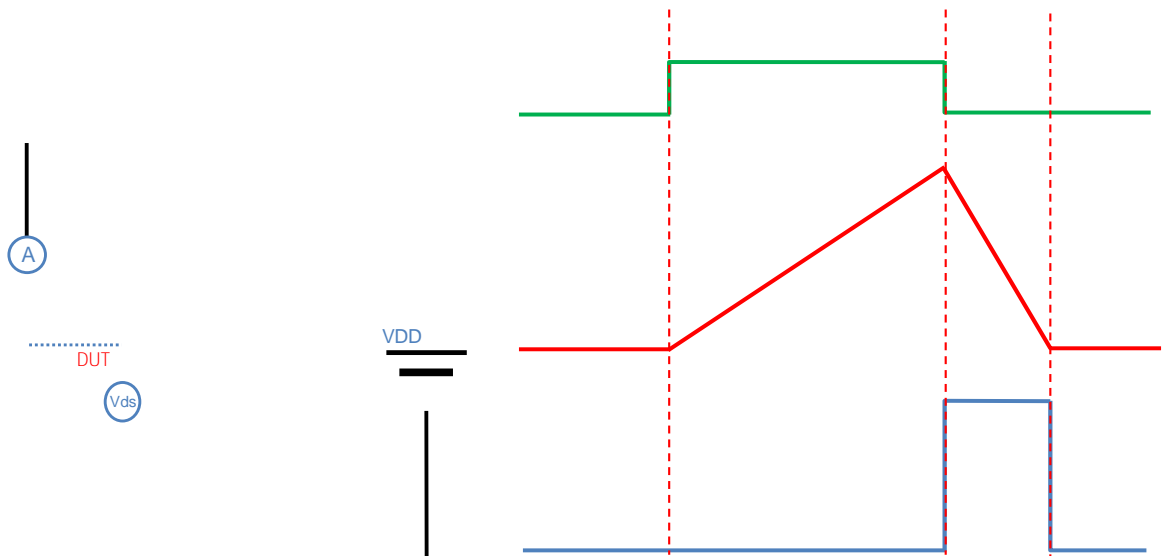


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



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Figure B. Gate Charge Test Circuit & Waveform



Figure C. Resistive Switching Test Circuit & Waveform

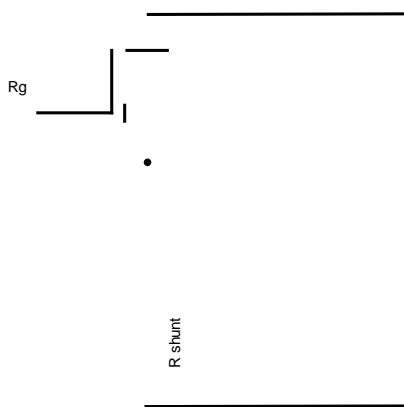


Figure D. Diode Recovery Test Circuit & Waveform



